

SILICON POWER TRANSISTOR 2SA1648, 2SA1648-Z

PNP SILICON EPITAXIAL TRANSISTOR FOR HIGH-SPEED SWITCHING

The 2SA1648 is a mold power transistor developed for highspeed switching and features a very low collector-to-emitter saturation voltage.

This transistor is ideal for use in switching regulators, DC/DC converters, motor drivers, solenoid drivers, and other low-voltage power supply devices, as well as for high-current switching.

FEATURES

- Available for high-current control in small dimension
- Z type is a lead processed product and is deal for mounting a hybrid IC.
- Mold package that does not require an insulating board or insulation bushing
- Low collector saturation voltage:
 VcE(sat) = -0.3 V MAX. (@Ic = -3 A)
- Fast switching speed:
 tf = 0.3 µs MAX. (@Ic = -3 A)
- · High DC current gain and excellent linearity

ABSOLUTE MAXIMUM RATINGS (Ta = 25 °C)

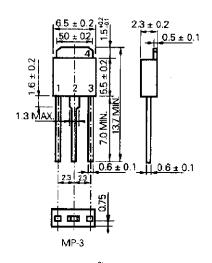
Parameter	Symbol	Ratings	Unit
Collector to base voltage	Vсво	-100	٧
Collector to emitter voltage	VCEO	-60	٧
Emitter to base voltage	VEBO	-7.0	٧
Collector current (DC)	Ic(DC)	-5.0	Α
Collector current (pulse)	IC(pulse)*	-10	Α
Base current (DC)	I _{B(DC)}	-2.5	Α
Total power dissipation	Рт (Tc = 25 °C)	18	W
Total power dissipation	P⊤ (Ta = 25 °C)	1.0**, 2.0***	W
Junction temperature	Tj	150	°C
Storage temperature	T _{stg}	-55 to +150	°C

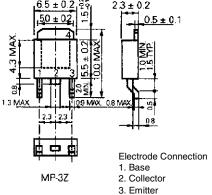
*: PW \leq 300 μ s, duty cycle \leq 10%

**: Printing board mounted

***: 7.5 mm² × 0.7 mm ceramic board mounted

PACKAGE DRAWING (UNIT: mm)





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ELECTRICAL CHARACTERISTICS (Ta = 25°C)

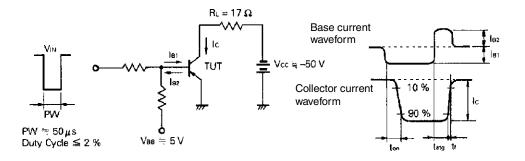
Parameter	Symbol	Conditions	MIN.	TYP.	MAX.	Unit
Collector to emitter voltage	VCEO(SUS)	Ic = -3.0 A, Iв = -0.3 A, L = 1 mH	-60			V
Collector to emitter voltage	VCEX(SUS)	$Ic = -3.0 \text{ A}, I_{B2} = -I_{B1} = -0.3 \text{ A},$ $V_{BE(OFF)} = 1.5 \text{ V}, L = 180 \ \mu\text{H}, clamped}$ -60				V
Collector cutoff current	Ісво	Vce = -60 V, IE = 0			-10	μΑ
Collector cutoff current	ICER	Vce = -60 V, Rbe = 50 Ω , Ta = 125 °C			-1.0	mA
Collector cutoff current	ICEX1	Vce = -60 V, Vbe(OFF) = 1.5 V			-10	μΑ
Collector cutoff current	ICEX2	$V_{CE} = -60 \text{ V}, V_{BE(OFF)} = 1.5 \text{ V},$ $Ta = 125 \text{ °C}$			-1.0	mA
Emitter cutoff current	ІЕВО	V _{EB} = -5.0 V, I _C = 0			-10	μΑ
DC current gain	hFE1*	Vce = -2.0 V, Ic = -0.5 A	100			
DC current gain	h _{FE2} *	Vce = -2.0 V, Ic = -1.0 A	100	200	400	
DC current gain	h _{FE3} *	$V_{CE} = -2.0 \text{ V, Ic} = -3.0 \text{ A}$	60			
Collector saturation voltage	VCE(sat)1*	Ic = -3.0 A, IB = -0.15 A			-0.3	V
Collector saturation voltage	VCE(sat)2*	Ic = -4.0 A, I _B = -0.2 A			-0.5	V
Base saturation voltage	VBE(sat)1*	Ic = -3.0 A, Iв = -0.15 A			-1.2	V
Base saturation voltage	V _{BE(sat)2} *	Ic = -4.0 A, IB = -0.2 A			-1.5	V
Collector capacitance	Cob	$V_{CB} = -10 \text{ V}, I_E = 0, f = 1.0 \text{ MHz}$		80		pF
Gain bandwidth product	f⊤	Vce = -10 V, Ic = 0.5 A		90		MHz
Turn-on time	ton	Ic = -3.0 A, RL = 17 Ω ,			0.3	μs
Storage time	tstg	$I_{B1} = -I_{B2} = -0.15 \text{ A}, \text{ Vcc } \cong -50 \text{ V}$ Refer to the test circuit.			1.5	μs
Fall time	tf	Trofer to the test circuit.			0.3	μs

^{*} Pulse test PW \leq 350 μ s, duty cycle \leq 2%/Pulsed

hfe CLASSIFICATION

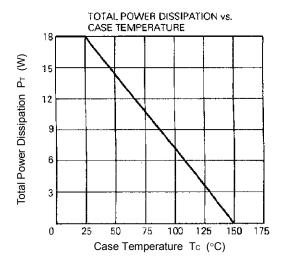
Marking	М	L	K
h _{FE2}	100 to 200	150 to 300	200 to 400

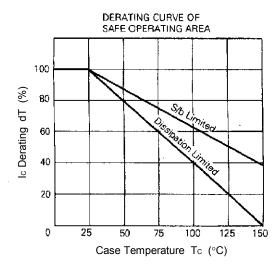
SWITCHING TIME TEST CIRCUIT

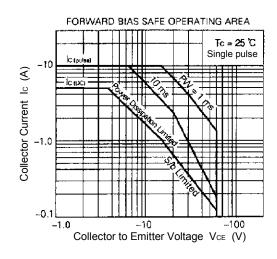


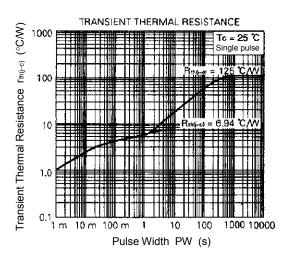


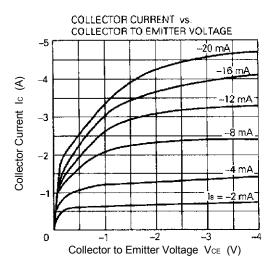
TYPICAL CHARACTERISTICS (Ta = 25°C)

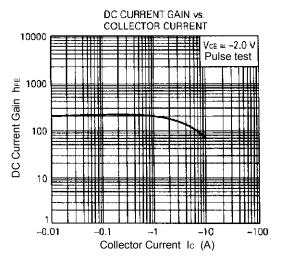


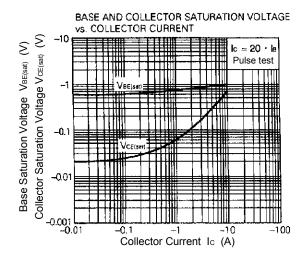


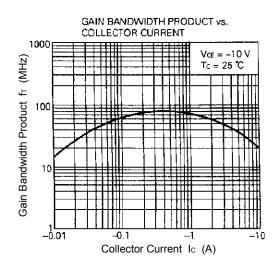


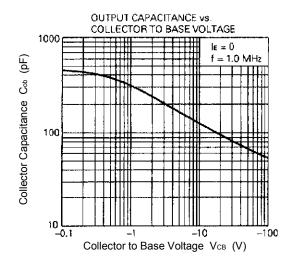


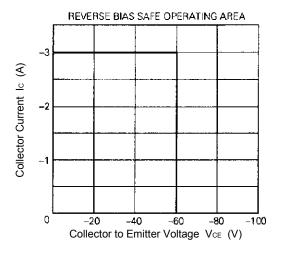


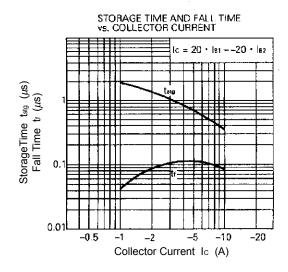














[MEMO]

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